

950V N-Channel MOSFET

Description

The MS6N95 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220 package is universally preferred for all commercial-industrial applications

- Features
- RDS(on) (Max 2.4 Ω)@VGS=10V •
- Gate Charge (Typical 33nC)
- Improved dv/dt Capability, High Ruggedness ٠
- 100% Avalanche Tested
- Maximum Junction Temperature Range (150°C) •
- RoHS compliant package •

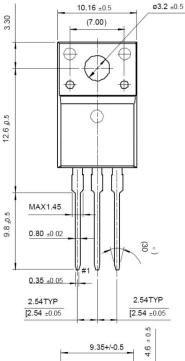
Application

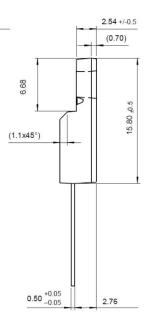
- Adapter
- Switching Mode Power Supply

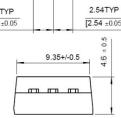
Packing & Order Information

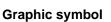
50/Tube ; 1,000/Box

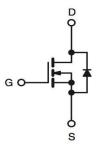












MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise specified)							
Symbol	Parameter	Value	Unit				
V _{DSS}	Drain-Source Voltage	950	V				
I _D	Drain Current -Continuous (TC=25°C)	6	A				
	Drain Current -Continuous (TC=100°C)	3.8	A				
I _{DM}	Drain Current –Pulsed	24	A				
V _{GS}	Gate-Source Voltage	±30	V				
E _{AS}	Single Pulsed Avalanche Energy	650	mJ				
E _{AR}	Repetitive Avalanche Energy	16.7	mJ				
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns				



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Absolute Maximum Ratings (Tc=25°C unless otherwise specified)					
Symbol	Parameter	Value	Unit		
P _D	Power Dissipation (TC=25°C)	56	W		
	- Derate above 25°C	0.48	W/°C		
T _J /T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C		
TL	Maximum lead temperature for soldering purposes, 1/8" from	200	•		
	case for 5 seconds	300	°C		

•Drain current limited by maximum junction temperature

Thermal Resistance Characteristics						
Symbol	Parameter	Тур.	Max.	Units		
$R_{ extsf{ heta}JC}$	Junction-to-Case		2.25	°C/W		
$R_{ extsf{ heta}JA}$	Junction-to-Ambient		62.5	C/W		

On Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
V _{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0		5.0	V
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$, $I_D = 3 \text{ A}$		1.95	2.40	Ω

Off Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V , I_{D} = 250 μA	900			V
∆BV _{dss} /∆Tj	Breakdown Voltage Temperature Coefficient	I_D =250µA , Referenced to 25°C		0.6		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 950 \text{ V}$, $V_{GS} = 0 \text{ V}$ $V_{DS} = 720 \text{ V}$, $V_C = 125 \text{ °C}$			10 100	μA
I _{GSSF}	Gate-Body Leakage Current,Forward	$V_{\rm GS}{=}30$ V , $V_{\rm DS}{=}0$ V			100	μA
I _{GSSR}	Gate-Body Leakage Current,Reverse	$V_{GS} = -30V$, $V_{DS} = 0$ V			-100	nA

Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
C _{ISS}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0MHz		1500		pF	
C _{OSS}	Coss Output Capacitance			120		pF	
C _{RSS}	Crss Reverse Transfer Capacitance			12		pF	



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Switching Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
t _{d(on)}	Turn-On Time	$V_{DS} = 450 \text{ V}, \text{ I}_{D} = 6 \text{ A},$ $R_{G} = 25 \Omega$		50		ns	
t _r	Turn-On Rise Time			100		ns	
t _{d(off)}	Turn-Off Delay Time			50		ns	
tf	Turn-Off Fall Time			60		ns	
Qg	Total Gate Charge			33		nC	
Q _{gs}	Gate-Source Charge	$V_{DS} = 720 \text{ V}, \text{ I}_{D} = 6 \text{ A},$ $V_{GS} = 10 \text{ V}$		10		nC	
Q _{gd}	Gate-Drain Charge	VGS - IV V		13		nC	

Source-Drain Diode Maximum Ratings and Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
I _S	Continuous Source-Drain Diode Forwa	ard Current			6.0		
I _{SM}	ISM Pulsed Source-Drain Diode Forwa	ard Current			24.0	A	
V_{SD}	Source-Drain Diode Forward Voltage	$I_{\rm S}$ = 6 A , $V_{\rm GS}$ = 0 V			1.4	V	
T _{rr}	Reverse Recovery Time	$I_{S} = 6 A$, $V_{GS} = 0 V$		0.65		ns	
Q _{rr}	Reverse Recovery Charge	diF/dt=100A/µs		7.0		μC	

Notes:

1. Repeativity rating : pulse width limited by junction temperature

2. L = 34.0mH, I_{AS} =6.0A, V_{DD} = 50V, R_{G} = 25 Ω , Starting TJ = 25°C

3. $I_{SD} \le 6.0A$, di/dt $\le 200A/us$, VDD $\le BVDSS$, Starting TJ = 25°C

4. Pulse Test : Pulse Width \leq 300us, Duty Cycle \leq 2%

5. Essentially independent of operating temperature.



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